## Notice of References Cited Application/Control No. 10/599,857 Applicant(s)/Patent Under Reexamination NAKAGAWA ET AL. Examiner CHRISTOPHER T. WYLLIE Applicant(s)/Patent Under Reexamination NAKAGAWA ET AL. Page 1 of 1

## U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	Α	US-5,507,035 A	04-1996	Bantz et al.	455/133
*	В	US-2002/0003774 A1	01-2002	Wang et al.	370/208
*	С	US-2002/0164968 A1	11-2002	Crawford, James A.	455/277.1
*	D	US-2003/0128678 A1	07-2003	Subrahmanya et al.	370/335
*	Е	US-6,977,910 B1	12-2005	Hosur et al.	370/318
	F	US-			
	G	US-			
	Н	US-			
	ı	US-			
	7	US-			
	K	US-			
	┙	US-			
	М	US-			

## FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	0					
	Р					
	Ø					
	R					
	Ø					
	Т					

## **NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)					
	C						
	>						
	w						
	х						

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)

Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.